

PACKAGE MATERIAL DECLARATION DATASHEET

Cypress Package Code	LT	Body Size (mil/mm)	8.0X8.0X1.0mm
Package Weight – Site 1	182.4898 mg	Package Weight – Site 2	192.0681 mg
Package Weight – Site 3	167.1409 mg	Package Weight – Site 4	B1: 179.3670 mg
	_	_	B2: 179.2000 mg
			B3. 177.6643 mg
			B4. 177.3193 mg
Package Weight – Site 5	B1: 170.0300 mg	Package Weight – Site 6	N/A
	B2: 174.9565 mg		

SUMMARY

The QFN 68L Pb-Free package is compliant to RoHS. Cypress Ordering Part Numbers containing an "X" (e.g. CY7C1328G-133AXI, CY2308SXC-1HT) meet the Directive 2002/95/EC (RoHS) requirement.

ASSEMBLY Site 1: PT UNISEM Batam Package Qualification Report # 072603 (See Note 1)

I. DECLARATION OF PACKAGED UNITS

A. BANNED SUBSTANCES

Substances / Compounds	Weight by mg	PPM	Analysis Report (Note 2)
Cadmium and Cadmium Compounds	0	< 5.0	
Hexavalent Chromium and its Compounds	0	< 5.0	
Lead and Lead Compounds	0	< 5.0	CoA-LT68-PT
Mercury and Mercury Compounds	0	< 5.0	UNISEM
Polybrominated Biphenyls (PBB)	0	< 5.0	
Polybrominated Diphenylethers (PBDE)	0	< 5.0	
Asbestos	0	0	As per MSDS
Azo colorants	0	0	As per MSDS
Ozone Depleting Substances	0	0	As per MSDS
Polychlorinated Biphenyls (PCBs)	0	0	As per MSDS
Polychlorinated Napthalenes	0	0	As per MSDS
Radioactive Substances	0	0	As per MSDS
Shortchain Chlorinated Paraffins	0	0	As per MSDS
Tributyl Tin (TBT) and Triphenyl Tin (TPT)	0	0	As per MSDS
Tributyl Tin Oxide (TBTO)	0	0	As per MSDS
Formaldehyde	0	0	As per MSDS

Note 1: Qualification reports are available at www.cypress.com. Access them by doing a Search on the Report #.

Note 2: Report available from Cypress Sales Offices or Distributors.

Note 3: Materials/substances not declared in Section I-A and I-B of this document are considered "non-existent in the product" or a natural impurity. In order to report exactly 100% material composition, some numbers were rounded to the nearest 0.01 percent. Cypress Semiconductor PMDD's are calculated using MSDS, Material Analysis Reports and Cypress Assembly site information.

Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



B. MATERIAL COMPOSITION (Note 3)

Material	Purpose of Use	Substance Composition	CAS Number	Weight by mg	% weight of substance per Homogeneous material	PPM	% weight of substance per package
		Cu	7440-50-8	72.4900	99.0700%	397228	39.7228
	Base Material	Si	7440-21-3	0.5500	0.7500%	3014	0.3014
		Mg	7439-95-4	0.1300	0.1800%	712	0.0712
Leadframe		Ni	7440-50-8	3.4000	97.7000%	18631	1.8631
	External	Pd	7440-05-3	0.0400	1.1500%	219	0.0219
	Plating	Au	7440-57-5	0.0200	0.5700%	110	0.0110
		Ag	7440-22-4	0.0200	0.5700%	110	0.0110
	Adhesive	Silver	7440-22-4	2.0919	75.0000%	11463	1.1463
		Epoxy resin	Proprietary	0.4185	15.0000%	2293	0.2293
		t-Butyl	3101-60-8	0.2093	7.5000%	1147	0.1147
Die Attach		Phenylglycidyl ether					
		Dicyadiamide	461-58-5	0.0140	0.5000%	76	0.0076
		Hardener	620-92-8	0.0561	2.0100%	307	0.0307
Die	Circuit	Si	7440-21-3	7.6100	100.0000%	41701	4.1701
Wire	Interconnect	Au	7440-57-5	2.3400	100.0000%	12823	1.2823
		Silica Fused	60676-86-0	87.2347	93.7000%	478025	47.8025
Malal Carenaviral		Epoxy Resin1	Trade Secret	2.7930	3.0000%	15305	1.5305
Mold Compound	Encapsulation	Phenol Resin	Trade Secret	2.7930	3.0000%	15305	1.5305
		Carbon Black	1333-86-4	0.2793	0.3000%	1530	0.1530
Package Weight (mg): 182.4898 % Total: 100.0000							

II. DECLARATION OF PACKAGING / INDIRECT MATERIALS

Туре	Material	Lead PPM	Cadmiu m PPM	Cr VI PPM	Mercury PPM	PBB PPM	PBDE PPM	Analysis Report (Note2)
	Cover tape	< 2.0	< 2.0	< 2.0	< 2.0	<5.0	<5.0	CoA-COVT-R
Tape & Reel	Carrier tape	< 2.0	< 2.0	< 2.0	< 2.0	<5.0	<5.0	CoA-CART-R
	Plastic Reel	< 2.0	< 2.0	< 2.0	< 2.0	< 0.0005	< 0.0005	CoA-PLRL-R
Tray	Tray	< 2.0	< 2.0	< 2.0	< 2.0	<5.0	<5.0	CoA-TRAY-R
Others	Shielding bag	< 2.0	< 2.0	< 2.0	< 2.0	<5.0	<5.0	CoA-SBAG -R

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Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



ASSEMBLY Site 2: Advanced Semiconductor Engineering Shanghai Package Qualification Report # 084005 (See Note 1)

I. DECLARATION OF PACKAGED UNITS

A. BANNED SUBSTANCES

Substances / Compounds	Weight by mg	РРМ	Analysis Report (Note 2)
Cadmium and Cadmium Compounds	0	< 5.0	
Hexavalent Chromium and its Compounds	0	< 5.0	
Lead and Lead Compounds	0	< 5.0	CoA-LT68-
Mercury and Mercury Compounds	0	< 5.0	ASE Shanghai
Polybrominated Biphenyls (PBB)	0	< 5.0	
Polybrominated Diphenylethers (PBDE)	0	< 5.0	
Asbestos	0	0	As per MSDS
Azo colorants	0	0	As per MSDS
Ozone Depleting Substances	0	0	As per MSDS
Polychlorinated Biphenyls (PCBs)	0	0	As per MSDS
Polychlorinated Napthalenes	0	0	As per MSDS
Radioactive Substances	0	0	As per MSDS
Shortchain Chlorinated Paraffins	0	0	As per MSDS
Tributyl Tin (TBT) and Triphenyl Tin (TPT)	0	0	As per MSDS
Tributyl Tin Oxide (TBTO)	0	0	As per MSDS
Formaldehyde	0	0	As per MSDS

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Note 2: Report available from Cypress Sales Offices or Distributors.

Note 3: Materials/substances not declared in Section I-A and I-B of this document are considered "non-existent in the product" or a natural impurity. In order to report exactly 100% material composition, some numbers were rounded to the nearest 0.01 percent. Cypress Semiconductor PMDD's are calculated using MSDS, Material Analysis Reports and Cypress Assembly site information.

Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



B. MATERIAL COMPOSITION (Note 3)

Material	Purpose of Use	Substance Composition	CAS Number	Weight by mg	% weight of substance per Homogeneous material	PPM	% weight of substance per package
		Cu	7440-50-8	72.8715	97.5000%	379,404	37.9404
	Dana Matarial	Fe	7439-89-6	1.7414	2.3300%	9,067	0.9067
	Base Material	Zn	7440-66-6	0.1121	0.1500%	584	0.0584
Leadframe		Р	7723-14-0	0.0224	0.0300%	117	0.0117
Leauname		Ni	7440-02-0	0.9100	92.8600%	4,738	0.4738
	External Disting	Pd	7440-05-3	0.0400	4.0800%	208	0.0208
	External Plating	Au	7440-57-5	0.0200	2.0400%	104	0.0104
		Ag	7440-22-4	0.0100	1.0200%	52	0.0052
	Adhesive	Silver	7440-22-4	0.7546	77.0000%	3,929	0.3929
		Acrylic resin	proprietary	0.0784	8.0000%	408	0.0408
		Epoxy resin	Proprietary	0.0245	2.5000%	128	0.0128
Die Attach		Polybutadiene derivative	proprietary	0.0490	5.0000%	255	0.0255
Die Attach		Butadiene copolymer	proprietary	0.0098	1.0000%	51	0.0051
		Acrylate	proprietary	0.0490	5.0000%	255	0.0255
		Peroxide	proprietary	0.0049	0.5000%	26	0.0026
		Additive	proprietary	0.0098	1.0000%	51	0.0051
Die	Circuit	Si	7440-21-3	7.6800	100.0000%	39,986	3.9986
Wire	Interconnect	Au	7440-57-5	1.0395	99.0000%	5,412	0.5412
		Pd	7440-05-3	0.0105	1.0000%	55	0.0055
		Silica Fused	60676-86-0	90.4244	84.8100%	470,793	47.0793
Mold	F	Epoxy Resin	Trade Secret	8.3590	7.8400%	43,521	4.3521
Compound	Encapsulation	Phenol Resin	Trade Secret	7.3248	6.8700%	38,136	3.8136
		Carbon Black	1333-86-4	0.5224	0.4900%	2,720	0.2720
		Package	Weight (mg):	192.0681		% Total:	100.0000

II. DECLARATION OF PACKAGING / INDIRECT MATERIALS

Туре	Material	Lead PPM	Cadmium PPM	Cr VI PPM	Mercury PPM	PBB PPM	PBDE PPM	Analysis Report (Note2)
	Cover tape	< 2.0	< 2.0	< 2.0	< 2.0	< 5.0	<5.0	CoA-COVT-R
Tape & Reel	Carrier tape	< 2.0	< 2.0	< 2.0	< 2.0	<5.0	<5.0	CoA-CART-R
	Plastic Reel	< 2.0	< 2.0	< 2.0	< 2.0	< 0.0005	< 0.0005	CoA-PLRL-R
Tray	Tray	< 2.0	< 2.0	< 2.0	< 2.0	<5.0	<5.0	CoA-TRAY-R
Others	Shielding bag	< 2.0	< 2.0	< 2.0	< 2.0	<5.0	<5.0	CoA-SBAG –R

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Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



ASSEMBLY Site 3: CARSEM Malaysia
Package Qualification Report # 101401 (See Note 1)

I. DECLARATION OF PACKAGED UNITS

A. BANNED SUBSTANCES

Substances / Compounds	Weight by mg	PPM	Analysis Report (Note 2)
Cadmium and Cadmium Compounds	0	< 5.0	
Hexavalent Chromium and its Compounds	0	< 5.0	
Lead and Lead Compounds	0	< 5.0	CoA-LT68-
Mercury and Mercury Compounds	0	< 5.0	CARSEM
Polybrominated Biphenyls (PBB)	0	< 5.0	
Polybrominated Diphenylethers (PBDE)	0	< 5.0	
Asbestos	0	0	As per MSDS
Azo colorants	0	0	As per MSDS
Ozone Depleting Substances	0	0	As per MSDS
Polychlorinated Biphenyls (PCBs)	0	0	As per MSDS
Polychlorinated Napthalenes	0	0	As per MSDS
Radioactive Substances	0	0	As per MSDS
Shortchain Chlorinated Paraffins	0	0	As per MSDS
Tributyl Tin (TBT) and Triphenyl Tin (TPT)	0	0	As per MSDS
Tributyl Tin Oxide (TBTO)	0	0	As per MSDS
Formaldehyde	0	0	As per MSDS

Note 1: Qualification reports are available at www.cypress.com. Access them by doing a Search on the Report #.

Note 2: Report available from Cypress Sales Offices or Distributors.

Note 3: Materials/substances not declared in Section I-A and I-B of this document are considered "non-existent in the product" or a natural impurity. In order to report exactly 100% material composition, some numbers were rounded to the nearest 0.01 percent. Cypress Semiconductor PMDD's are calculated using MSDS, Material Analysis Reports and Cypress Assembly site information.

Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



B. MATERIAL COMPOSITION (Note 3)

Material	Purpose of Use	Substance Composition	CAS Number	Weight by mg	% weight of substance per Homogeneous material	PPM	% weight of substance per package
		Cu	7440-50-8	62.8280	97.6500%	375898	37.5898
	Base Material	Fe	7439-89-6	1.4219	2.2100%	8507	0.8507
	Dase Material	Р	7723-14-0	0.0129	0.0200%	77	0.0077
Leadframe		Zn	7440-66-6	0.0579	0.0900%	346	0.0346
Leadirame	External Plating	Ni	7440-50-8	0.5602	93.3600%	3352	0.3352
		Pd	7440-05-3	0.0100	1.6700%	60	0.0060
		Au	7440-57-5	0.0200	3.3300%	120	0.0120
		Ag	7440-22-4	0.0100	1.6700%	60	0.0060
		Silver	7440-22-4	0.3195	71.0000%	1912	0.1912
		Bismaleimide resin	Proprietary	0.0135	3.0000%	81	0.0081
Die Attach	Adhesive	Carbocycllic Acrylate	Proprietary	0.0900	20.0000%	538	0.0538
		Acrylate	Propietary	0.0135	3.0000%	81	0.0081
		Additive	Proprietary	0.0135	3.0000%	81	0.0081
Die	Silicon Chip	Si	7440-21-3	1.3300	100.0000%	7957	0.7957
Wire	Interconnect	Au	7440-57-5	2.4600	100.0000%	14718	1.4718
•		Silica Fused	60676-86-0	91.8073	93.7000%	549281	54.9281
Mold	Francislation	Epoxy Resin1	Trade Secret	2.9394	3.0000%	17586	1.7586
Compound	Encapsulation	Phenol Resin	Trade Secret	2.9394	3.0000%	17586	1.7586
•		Carbon Black	1333-86-4	0.2939	0.3000%	1759	0.1759
Package Weight (mg): 167.1409							

II. DECLARATION OF PACKAGING / INDIRECT MATERIALS

Туре	Material	Lead PPM	Cadmium PPM	Cr VI PPM	Mercury PPM	PBB PPM	PBDE PPM	Analysis Report (Note2)
	Cover tape	< 2.0	< 2.0	< 2.0	< 2.0	<5.0	<5.0	CoA-COVT-R
Tape & Reel	Carrier tape	< 2.0	< 2.0	< 2.0	< 2.0	<5.0	<5.0	CoA-CART-R
	Plastic Reel	< 2.0	< 2.0	< 2.0	< 2.0	< 0.0005	< 0.0005	CoA-PLRL-R
Tray	Tray	< 2.0	< 2.0	< 2.0	< 2.0	<5.0	<5.0	CoA-TRAY-R
Others	Shielding bag	< 2.0	< 2.0	< 2.0	< 2.0	<5.0	<5.0	CoA-SBAG -R

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Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



ASSEMBLY Site 4: Cypress Manufacturing Limited (CML)
Package Qualification Report # 100401, 114407, 120206 (See Note 1)

I. DECLARATION OF PACKAGED UNITS

A. BANNED SUBSTANCES

Substances / Compounds	Weight by mg	РРМ	Analysis Report (Note 2)
Cadmium and Cadmium Compounds	0	< 5.0	
Hexavalent Chromium and its Compounds	0	< 5.0	
Lead and Lead Compounds	0	< 5.0	CoA-LT68-
Mercury and Mercury Compounds	0	< 5.0	CML
Polybrominated Biphenyls (PBB)	0	< 5.0	
Polybrominated Diphenylethers (PBDE)	0	< 5.0	
Asbestos	0	0	As per MSDS
Azo colorants	0	0	As per MSDS
Ozone Depleting Substances	0	0	As per MSDS
Polychlorinated Biphenyls (PCBs)	0	0	As per MSDS
Polychlorinated Napthalenes	0	0	As per MSDS
Radioactive Substances	0	0	As per MSDS
Shortchain Chlorinated Paraffins	0	0	As per MSDS
Tributyl Tin (TBT) and Triphenyl Tin (TPT)	0	0	As per MSDS
Tributyl Tin Oxide (TBTO)	0	0	As per MSDS
Formaldehyde	0	0	As per MSDS

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Note 2: Report available from Cypress Sales Offices or Distributors.

Note 3: Materials/substances not declared in Section I-A and I-B of this document are considered "non-existent in the product" or a natural impurity. In order to report exactly 100% material composition, some numbers were rounded to the nearest 0.01 percent. Cypress Semiconductor PMDD's are calculated using MSDS, Material Analysis Reports and Cypress Assembly site information.

Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



B1. MATERIAL COMPOSITION (Note 3)

USING GOLD WIRE AND NITTO MOLD COMPOUND

Material	Purpose of Use	Substance Composition	CAS Number	Weight by mg	% weight of substance per Homogeneo us material	PPM	% weight of substance per package
		Copper	7440-50-8	74.3345	97.4100%	414,427	41.4427%
Lead	Base material	Iron	7439-89-6	1.8315	2.4000%	10,211	1.0211%
Frame		Phosphorous	7723-14-0	0.0534	0.0700%	298	0.0298%
	Zinc	7440-66-6	0.0916	0.1200%	511	0.0511%	
	Este mad	Nickel	7440-02-0	1.1476	96.5200%	6,398	0.6398%
Lead Finish	External	Palladium	7440-05-3	0.0207	1.7370%	115	0.0115%
	Plating	Gold	7440-57-5	0.0207	1.7430%	116	0.0116%
		Ag	7440-22-4	0.7866	74.0000%	4,386	0.4386%
		Carbocyclic Acrylate		0.2126	20.0000%	1,185	0.1185%
Die Attach	Adhesive	Bismaleimide Resin		0.0213	2.0000%	119	0.0119%
		Additive		0.0213	2.0000%	119	0.0119%
		Acrylate ester		0.0213	2.0000%	119	0.0119%
Die	Circuit	Silicon	7440-21-3	14.8850	100.0000%	82,986	8.2986%
Wire	Interconnect	Gold	7440-57-5	3.1314	99.0000%	17,458	1.7458%
vvire	interconnect	Palladium	7440-05-3	0.0316	1.0000%	176	0.0176%
		SiO2	60676-86-0	69.1013	83.5000%	385,251	38.5251%
		Crystalline Silica	14808-60-7	4.1378	5.0000%	23,069	2.3069%
Mold	Encapsulation	Metal OH		2.4827	3.0000%	13,841	1.3841%
Compound	'	Phenol Resin		3.3102	4.0000%	18,455	1.8455%
•		Epoxy Resin		3.3102	4.0000%	18,455	1.8455%
		Carbon Black	1333-86-4	0.4138	0.5000%	2,307	0.2307%
	Package Weight (mg): 179.3671 % Total: 100.000						

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B2. MATERIAL COMPOSITION (Note 3)

USING GOLD WIRE AND SUMITOMO MOLD COMPOUND

Material	Purpose of Use	Substance Composition	CAS Number	Weight by mg	% weight of substance per Homogeneous material	PPM	% weight of substance per package
		Copper	7440-50-8	74.3354	97.4100%	414,818	41.4818%
Lead	Base material	Iron	7439-89-6	1.8315	2.4000%	10,220	1.0220%
Frame	Dase material	Phosphorous	7723-14-0	0.0534	0.0700%	298	0.0298%
		Zinc	7440-66-6	0.0916	0.1200%	511	0.0511%
		Nickel	7440-02-0	1.1468	96.5200%	6,400	0.6400%
Lead Finish	External Plating	Palladium	7440-05-3	0.0206	1.7370%	115	0.0115%
1 1111311	riating	Gold	7440-57-5	0.0207	1.7430%	116	0.0116%
		Ag	7440-22-4	1.0642	74.0000%	5,939	0.5939%
	Adhesive	Carbocyclic Acrylate		0.2876	20.0000%	1,605	0.1605%
Die Attach		Bismaleimide Resin		0.0288	2.0000%	161	0.0161%
		Additive		0.0288	2.0000%	161	0.0161%
		Acrylate ester		0.0288	2.0000%	161	0.0161%
Die	Circuit	Silicon	7440-21-3	20.1341	100.0000%	112,356	11.2356%
Wire	Interconnect	Gold	7440-57-5	3.3260	99.0000%	18,560	1.8560%
vvire	Interconnect	Palladium	7440-05-3	0.0336	1.0000%	187	0.0187%
		SiO2	60676-86-0	67.3640	87.7500%	375,915	37.5915%
Mold	Consequenting:	Phenol Resin		3.8384	5.0000%	21,420	2.1420%
Compound	Encapsulation	Epoxy Resin		5.3738	7.0000%	29,988	2.9988%
		Carbon Black	1333-86-4	0.1919	0.2500%	1,071	0.1071%
		Package W	179.2000		% Total:	100.0000%	

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B3. MATERIAL COMPOSITION (Note 3)

USING COPPER WIRE AND NITTO MOLD COMPOUND

Material	Purpose of Use	Substance Composition	CAS Number	Weight by mg	% weight of substance per Homogeneo us material	PPM	% weight of substance per package
		Copper	7440-50-8	74.3345	97.4099%	418,399	41.8399%
Lead	Base material	Iron	7439-89-6	1.8315	2.4000%	10,309	1.0309%
Frame		Phosphorous	7723-14-0	0.0534	0.0700%	301	0.0301%
		Zinc	7440-66-6	0.0916	0.1200%	516	0.0516%
	External	Nickel	7440-02-0	1.1476	96.5181%	6,459	0.6459%
Lead Finish	Plating	Palladium	7440-05-3	0.0207	1.7410%	117	0.0117%
		Gold	7440-57-5	0.0207	1.7410%	117	0.0117%
	Adhesive	Ag	7440-22-4	0.7866	73.9912%	4,427	0.4427%
		Carbocyclic Acrylate		0.2126	19.9981%	1,197	0.1197%
Die Attach		Bismaleimide Resin		0.0213	2.0036%	120	0.0120%
		Additive		0.0213	2.0036%	120	0.0120%
		Acrylate ester		0.0213	2.0036%	120	0.0120%
Die	Circuit	Silicon	7440-21-3	14.885	100.0000%	83,782	8.3782%
Wire	Interconnect	Copper	7440-50-8	1.4602	100.0000%	8,219	0.8219%
		SiO2	60676-86-0	69.1013	83.5000%	388,943	38.8943%
		Crystalline Silica	14808-60-7	4.1378	5.0000%	23,290	2.3290%
Mold	Encapsulation	Metal OH		2.4827	3.0000%	13,974	1.3974%
Compound	•	Phenol Resin		3.3102	4.0000%	18,632	1.8632%
		Epoxy Resin		3.3102	4.0000%	18,632	1.8632%
		Carbon Black	1333-86-4	0.4138	0.5000%	2,329	0.2329%
		Package	Weight (mg):	177.6643		% Total:	100.0000

Note 1: Qualification reports are available at www.cypress.com. Access them by doing a Search on the Report #. Note 2: Report available from Cypress Sales Offices or Distributors.

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Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



B4. MATERIAL COMPOSITION (Note 3)

USING COPPER WIRE AND SUMITOMO MOLD COMPOUND

Material	Purpose of Use	Substance Composition	CAS Number	Weight by mg	% weight of substance per Homogeneous material	PPM	% weight of substance per package
		Copper	7440-50-8	74.3354	97.4100%	419,048	41.9048%
Lead	Base material	Iron	7439-89-6	1.8315	2.4000%	10,325	1.0325%
Frame	base material	Phosphorous	7723-14-0	0.0534	0.0700%	301	0.0301%
		Zinc	7440-66-6	0.0916	0.1200%	516	0.0516%
		Nickel	7440-02-0	1.1468	96.5239%	6,465	0.6465%
Lead Finish	External Plating	Palladium	7440-05-3	0.0206	1.7339%	116	0.0116%
1 111011	1 13 11 19	Gold	7440-57-5	0.0207	1.7423%	117	0.0117%
	Adhesive	Ag	7440-22-4	1.0642	73.9953%	5,999	0.5999%
		Carbocyclic Acrylate		0.2876	19.9972%	1,621	0.1621%
Die Attach		Bismaleimide Resin		0.0288	2.0025%	162	0.0162%
		Additive		0.0288	2.0025%	162	0.0162%
		Acrylate ester		0.0288	2.0025%	162	0.0162%
Die	Circuit	Silicon	7440-21-3	20.1341	100.0000%	113,501	11.3501%
Wire	Interconnect	Copper	7440-50-8	1.5509	100.0000%	8,743	0.8743%
		SiO2	60676-86-0	67.3640	87.7500%	379,748	37.9748%
Mold	Enconculation	Phenol Resin		3.8384	5.0000%	21,638	2.1638%
Compound	Encapsulation	Epoxy Resin		5.3738	7.0000%	30,293	3.0293%
		Carbon Black	1333-86-4	0.1919	0.2500%	1,082	0.1082%
		Package W	177.3913		% Total:	100.0000%	

II. DECLARATION OF PACKAGING / INDIRECT MATERIALS

Туре	Material	Lead PPM	Cadmium PPM	Cr VI PPM	Mercury PPM	PBB PPM	PBDE PPM	Analysis Report (Note2)
	Cover tape	< 2.0	< 2.0	< 2.0	< 2.0	<5.0	<5.0	CoA-COVT-R
Tape & Reel	Carrier tape	< 2.0	< 2.0	< 2.0	< 2.0	<5.0	<5.0	CoA-CART-R
-	Plastic Reel	< 2.0	< 2.0	< 2.0	< 2.0	<0.0005	< 0.0005	CoA-PLRL-R
Tray	Tray	< 2.0	< 2.0	< 2.0	< 2.0	<5.0	<5.0	CoA-TRAY-R
Others	Shielding bag	< 2.0	< 2.0	< 2.0	< 2.0	<5.0	<5.0	CoA-SBAG -R

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Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



ASSEMBLY Site 5: Advanced Semiconductor Engineering Taiwan (ASET) Package Qualification Report # 111816, 114906 (Note 1)

I. DECLARATION OF PACKAGED UNITS

A. BANNED SUBSTANCES

Substances / Compounds	Weight by mg	PPM	Analysis Report (Note 2)
Cadmium and Cadmium Compounds	0	< 5.0	
Hexavalent Chromium and its Compounds	0	< 5.0	
Lead and Lead Compounds	0	< 5.0	CoA-LT68-
Mercury and Mercury Compounds	0	< 5.0	ASET
Polybrominated Biphenyls (PBB)	0	< 5.0	
Polybrominated Diphenylethers (PBDE)	0	< 5.0	
Asbestos	0	0	As per MSDS
Azo colorants	0	0	As per MSDS
Ozone Depleting Substances	0	0	As per MSDS
Polychlorinated Biphenyls (PCBs)	0	0	As per MSDS
Polychlorinated Napthalenes	0	0	As per MSDS
Radioactive Substances	0	0	As per MSDS
Shortchain Chlorinated Paraffins	0	0	As per MSDS
Tributyl Tin (TBT) and Triphenyl Tin (TPT)	0	0	As per MSDS
Tributyl Tin Oxide (TBTO)	0	0	As per MSDS
Formaldehyde	0	0	As per MSDS

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Note 3: Materials/substances not declared in Section I-A and I-B of this document are considered "non-existent in the product" or a natural impurity. In order to report exactly 100% material composition, some numbers were rounded to the nearest 0.01 percent. Cypress Semiconductor PMDD's are calculated using MSDS, Material Analysis Reports and Cypress Assembly site information.

Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.



B1. MATERIAL COMPOSITION (Note 3)

USING GOLD WIRE

Material	Purpose of Use	Substance Composition	CAS Number	Weight by (mg)	% weight of substance per Homogeneous material	PPM	% weight of substance per package		
		Copper	7440-50-8	76.8582	97.4000%	451310	45.1311%		
Lead	Base material	Iron	7439-89-6	1.8938	2.4000%	11121	1.1121%		
Frame		Zinc	7440-66-6	0.1184	0.1500%	695	0.0695%		
		Phosphorus	7723-14-0	0.0395	0.0500%	232	0.0232%		
	Evete we al	Nickel	7440-02-0	1.0194	94.3900%	5986	0.5986%		
Lead Finish	External	Palladium	7440-05-3	0.0476	4.4100%	280	0.0280%		
	Plating	Gold	7440-57-5	0.0130	1.2000%	76	0.0076%		
	Adhesive	Silver	7440-22-4	1.4070	70.0000%	8262	0.8262%		
		Acrylic Resin		0.1508	7.5000%	885	0.0885%		
		Polybutadiene derivative		0.1859	9.2500%	1092	0.1092%		
Die Attach		Butadiene copolymer		0.0704	3.5000%	413	0.0413%		
		Acrylate		0.1508	7.5000%	885	0.0885%		
		Peroxide		0.0201	1.0000%	118	0.0118%		
		Additive		0.0251	1.2500%	148	0.0148%		
Die	Circuit	Silicon	7440-21-3	7.3000	100.0000%	42866	4.2866%		
Wire	Interconnect	Gold	7440-57-5	0.9999	99.9900%	5871	0.5871%		
vviie	merconnect	Ion Impurities		0.0001	0.0100%	1	0.0001%		
		Epoxy Resin A		3.6000	4.5000%	21139	2.1139%		
Mold	Engangulation	Epoxy Resin B		2.4000	3.0000%	14093	1.4093%		
Mold Compound	Encapsulation	Phenol Resin		5.2800	6.6000%	31004	3.1004%		
		Carbon Black	1333-86-4	0.4000	0.5000%	2349	0.2349%		
		Silica Fused	60676-86-0	68.3200	85.4000%	401174	40.1174%		
	Package Weight (mg): 170.0300 % Total: 100.0000								

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B2. MATERIAL COMPOSITION (Note 3)

USING COPPER WIRE

Material	Purpose of Use	Substance Composition	CAS Number	Weight by (mg)	% weight of substance per Homogeneous material	PPM	% weight of substance per package
		Copper	7440-50-8	91.5593	97.3000	523,322	52.3322
Lead	Base material	Iron	7439-89-6	2.3055	2.4500	13,177	1.3177
Frame		Zinc	7440-66-6	0.1506	0.1600	861	0.0861
		Phosphorus	7723-14-0	0.0847	0.0900	484	0.0484
	C. damad	Nickel	7440-02-0	1.2157	94.3880	6,949	0.6949
Lead Finish	External	Palladium	7440-05-3	0.0568	4.4120	325	0.0325
	Plating	Gold	7440-57-5	0.0155	1.2000	88	0.0088
	Adhesive	Silver	7440-22-4	1.1410	70.0000	6,522	0.6522
		Acrylic Resin		0.1223	7.5000	699	0.0699
		Polybutadiene derivative		0.1508	9.2500	862	0.0862
Die Attach		Butadiene copolymer		0.0571	3.5000	326	0.0326
		Acrylate		0.1223	7.5000	699	0.0699
		Peroxide		0.0163	1.0000	93	0.0093
		Additive		0.0204	1.2500	116	0.0116
Die	Circuit	Silicon	7440-21-3	13.9000	100.0000	79,447	7.9447
Wire	Interconnect	Copper	7440-50-8	0.4200	100.0000	2,400	0.2400
		Epoxy Resin A		2.8629	4.5000	16,363	1.6363
		Epoxy Resin B		1.9068	3.0000	10,909	1.0909
Mold	Encapsulation	Phenol Resin		4.1989	6.6000	24,000	2.4000
Compound		Carbon Black	1333-86-4	0.3181	0.5000	1,818	0.1818
		Silica Fused	60676-86-0	54.3315 174 9565	85.4000	310,540	31.0540

Package Weight (mg): | 174.9565 |

% Total: | 100.0000

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Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.

II. DECLARATION OF PACKAGING INDIRECT MATERIALS

Туре	Material	Lead PPM	Cadmium PPM	Cr VI PPM	Mercury PPM	PBB PPM	PBDE PPM	Analysis Report (Note2)
Tape &	Cover tape	<20.0	<20.0	<20.0	<20.0	<20.0	<20.0	CoA-COVT-R
Reel	Carrier tape	<5.0	<5.0	<5.0	<10.0	<50.0	<45.0	CoA-CART-R
Reei	Plastic Reel	< 5.0	< 5.0	< 5.0	< 10.0	<50.0	<45.0	CoA-PLRL-R
Tray	Tray	< 5.0	< 5.0	< 5.0	< 10.0	<50.0	<45.0	CoA-TRAY-R CoA-TRAY-M
Others	Shielding bag	<2 .0	<2.0	<2.0	<2.0	<5.0	<5.0	CoA-SBAG –R CoA-SBAG –M

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68L - QFN 8X8X1.0 mm (Saw Version) Pb-Free Package

Document History Page

Document Title: 68L - QFN 8X8X1.0MM (SAW VERSION) PB-FREE PACKAGE MATERIAL DECLARATION

DATASHEET

Document Number: 001-17657

Rev.	ECN No.	Orig. of Change	Description of Change
**	1362383	EBZ	Initial spec release.
*A	2600097	DPT	Added Assembly site 2 and change package thickness from 0.9 to 1.0mm per POD#001-09618. Update spec title to 68L – QFN 8X8X1.0 mm (Saw Version) PB- Free Package PMDD
		DCON	Changed CML to WEB in distribution list.
*B	3040449	HLR	Removed tube type on Indirect Material table.
*C	3113486	MLA	Add assembly site 3.
*D	3247365	JARG	Added Assembly Site 4 – CML RA Change category from Quality Standard to PMDD Category
*E	3414374	HLR	Updated the material composition table to reflect 4 decimal places on values.
*F	3485534	CMG	Added Package Weight Site 4 – B2 Added QTP# 114407 on Assembly Site 4 Added B2 material composition on Assembly Site 4
*G	3533023	COPI	Added Assembly Site 5 – Autoline RA Copper wire qualification. Reference QTP # 120206.
*H	3599270	JARG	Added Assembly Site 6 - ASE Assembled (Assembly Sites 2 and 3) from Spec 001-08151 in reference to QTPs 111816 and 114906 which reflects 8x8x1.0mm package dimension Updated the material composition table for Assembly Site 6 – B1 to reflect four decimal places on values.
*	4052508	YUM	Added assembly site name in the Assembly heading in site 1, 2, 3, 4 and 5. Changed assembly code to assembly site name in site 1, 2, 3, 4 and 5. Consolidate material composition in one assembly site. 1. CML 2. ASET

Distribution: WEB

Posting: None

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Note 4: Actual testing performed on package family basis. Engineering calculations were applied to derive individual package data.